

Application/Control	No.
10/653,719	

Examiner
John P. Leubecker

Applicant(s)/Patent under Reexamination
CHEN ET AL.

Art Unit 3739

				ISSUE	CL	<u>.AS</u>	SIF	ICAT	ION						
		ORIGINAL				INTERNATIONAL CLASSIFICATION									
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	Claims renumbered in the same order as presented by applicant										☐ CPA			<b>⊠</b> T.D.			☐ R.1.47		
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	2			32			62			92			122			152			182
	3			33			63			93			123			153			183
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	5			35			65			95			125			155			185
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	7			37			67			97			127			157			187
2	8			38			68			98			128			158			188
3	9			39			69			99			129			159			189
	10			40			70			100			130			160			190
	11			41			71			101			131			161			191
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	14			44			74			104			134			164			194
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	16			46			76			106			136			166			196
	17			47			77			107			137			167			197
	18			48			78			108			138			168			198
	19			49			79			109			139			169			199
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	24			54			84			114			144			174			204
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5	26			56			86			116			146			176			206
	27			57			87			117			147			177			207
	28			58			88			118			148			178			208
	29			59			89			119			149			179			209
	30			60			90			120			150			180			210